	 	notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,366	NERURKAR ET AL.	
Examiner	Art Unit	
Leigh C. Maier	1623	

	SEAD	CHED	
	JLAR	OIILD	
Class	Subclass	Date	Examiner
514	58 253.07	9/8/2005	LCM
search	updated	3/17/2006	LCM

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
514	58 253.07	3/17/2006	LCM

SEARCH (INCLUDING SEAR)
	DATE	EXMR
-STN text search -EAST (transcripts attached)	9/8/2005	LCM
-search updated in EAST	3/17/2006	LCM